60V, 218A, 1.9mΩ N-channel Power SGT MOSFET

JMSH0602PE

Features

- Excellent RDS(ON) and Low Gate Charge
- 100% UIS Tested
- 100% ΔVds Tested
- Halogen-free; RoHS-compliant

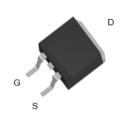
Product Summary

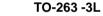
Parameters	Value	Unit
V_{DSS}	60	V
$V_{GS(th)_Typ}$	2.8	V
$I_D(@V_{GS}=10V)$	218	Α
$R_{DS(ON)_Typ}(@V_{GS}=10V$	1.9	mΩ

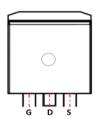


Applications

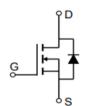
- Load Switch
- PWM Application
- Power Management







Pin Assignment



Schematic Diagram

Ordering Information

Device	Marking	MSL	Form	Package	Reel(pcs)	Per Carton (pcs)
JMSH0602PE-13	SH0602P	3	Tape&Reel	TO-263-3L	800	4000

Absolute Maximum Ratings (@ T_C = 25°C unless otherwise specified)

Symbol	Parameter		Value	Unit
V_{DS}	Drain-to-Source Voltage		60	V
V_{GS}	Gate-to-Source Voltage		±20	V
I-	Continuous Drain Current	$T_C = 25^{\circ}C$	218	Α
I _D	Continuous Drain Current	$T_C = 100$ °C	138	A
I _{DM}	Pulsed Drain Current (1)		Refer to Fig.4	Α
E _{AS}	Single Pulsed Avalanche Energy (2)		497	mJ
P _D	Power Dissipation	$T_C = 25^{\circ}C$	208	W
		$T_C = 100$ °C	83	V V
T_{J}, T_{STG}	Junction & Storage Temperature Range		-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Max	Unit
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient ⁽³⁾	41	9 0 /M
$R_{\theta JC}$	Thermal Resistance, Junction to Case	0.6	°C/W



Electrical Characteristics (T_J = 25°C unless otherwise specified)

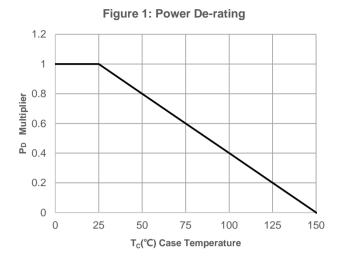
Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Off Characteristics						
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	60	-	-	V
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 48V, V_{GS} = 0V$	-	-	1.0	μА
I _{GSS}	Gate-Body Leakage Current	$V_{DS} = 0V, V_{GS} = \pm 20V$	-	-	±100	nA
On Cha	racteristics					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.9	2.8	3.6	V
R _{DS(ON)}	Static Drain-Source ON-Resistance ⁽⁴⁾	$V_{GS} = 10V, I_D = 20A$	-	1.9	2.5	mΩ
Dynami	ic Characteristics					
R_{g}	Gate Resistance	f = 1MHz	-	2.7	-	Ω
C _{iss}	Input Capacitance	\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \	2744	4574	6861	pF
C _{oss}	Output Capacitance	$V_{GS} = 0V, V_{DS} = 30V,$ f = 1MHz	1398	2330	3495	pF
C _{rss}	Reverse Transfer Capacitance		61	102	204	pF
Q_g	Total Gate Charge	1/ 01 /01/	42	70	105	nC
Q_{gs}	Gate Source Charge	$V_{GS} = 0 \text{ to } 10V$ $V_{DS} = 30V, I_{D} = 20A$	13	21	32	nC
Q_{gd}	Gate Drain("Miller") Charge	V DS = 00 V, ID = 20/1	10	17	26	nC
Switchi	ng Characteristics			1		
t _{d(on)}	Turn-On DelayTime		-	17	-	ns
t _r	Turn-On Rise Time	$V_{GS} = 10V, V_{DD} = 30V$	-	32	-	ns
$t_{d(off)}$	Turn-Off DelayTime	$I_D = 20A, R_{GEN} = 3\Omega$	-	46	-	ns
t _f	Turn-Off Fall Time		-	26	-	ns
Body D	iode Characteristics					
Is	Maximum Continuous Body Diode Forward Current		-	-	218	Α
I _{SM}	Maximum Pulsed Body Diode Forward Curre	e Forward Current		-	871	А
V _{SD}	Body Diode Forward Voltage	$V_{GS} = 0V, I_{S} = 20A$	-		1.2	V
trr	Body Diode Reverse Recovery Time	I _E = 20A, di/dt = 100A/us	39	65	98	ns
Qrr	Body Diode Reverse Recovery Charge	1F - 20A, al/at = 100A/as	-	87	-	nC

Notes:

- 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature.
- $2.~E_{AS}~condition:~Starting~T_J=25C,~V_{DD}=30V,~V_{GS}=10V,~R_G=25ohm,~L=3mH,~I_{AS}=18.2A,~V_{DD}=0V~during~time~in~avalanche.$
- 3. $\rm R_{\rm \theta JA}$ is measured with the device mounted on a 1inch 2 pad of 2oz copper FR4 PCB.
- 4. Pulse Test: Pulse Width≤300μs, Duty Cycle≤0.5%.



Typical Performance Characteristics



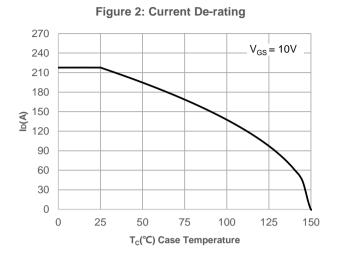


Figure 3: Normalized Maximum Transient Thermal Impedance

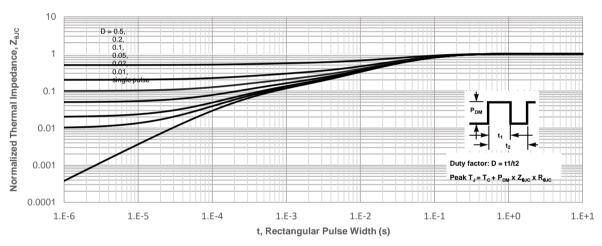
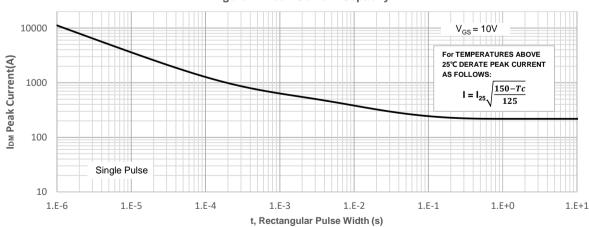


Figure 4: Peak Current Capacity





Typical Performance Characteristics

Figure 5: Output Characteristics

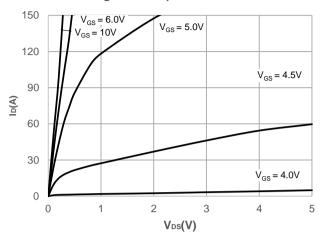


Figure 6: Typical Transfer Characteristics

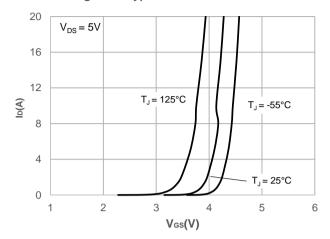


Figure 7: On-resistance vs. Drain Current

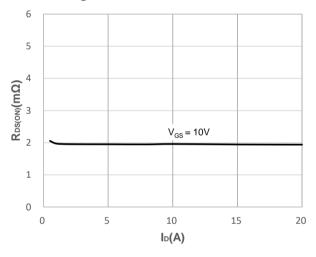


Figure 8: Body Diode Characteristics

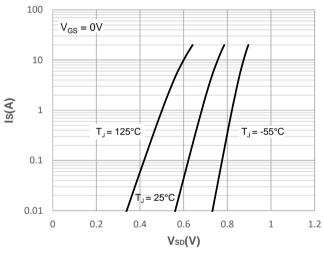


Figure 9: Gate Charge Characteristics

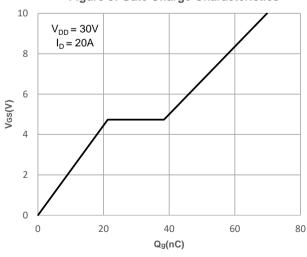
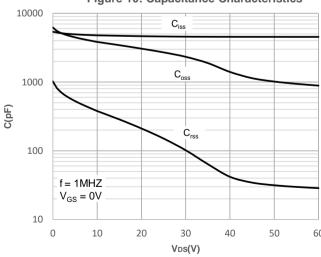


Figure 10: Capacitance Characteristics





Typical Performance Characteristics

Figure 11: Normalized Breakdown voltage vs. Junction Temperature

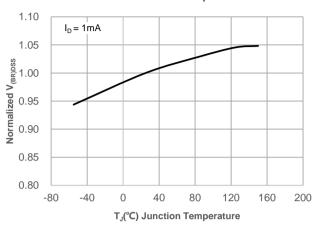


Figure 13: Normalized Threshold Voltage vs.
Junction Temperature

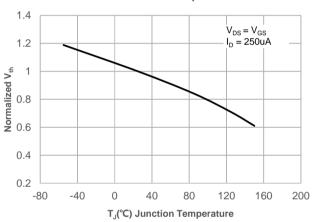


Figure 15: Maximum Safe Operating Area

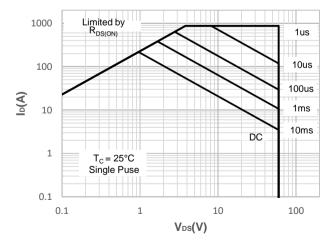
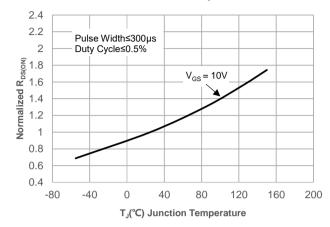
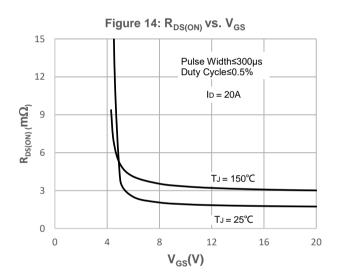


Figure 12: Normalized on Resistance vs. Junction Temperature







Test Circuit

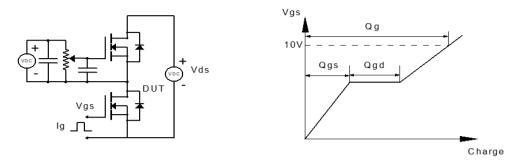


Figure 1: Gate Charge Test Circuit & Waveform

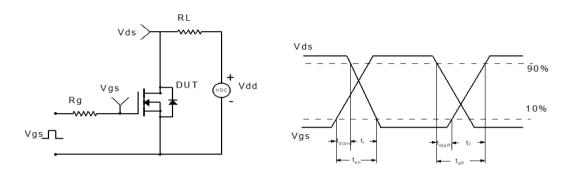


Figure 2: Resistive Switching Test Circuit & Waveform

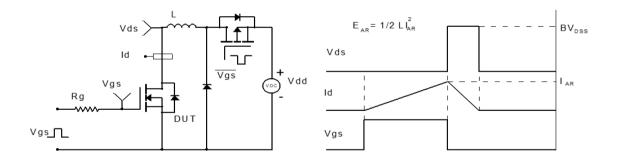


Figure 3: Unclamped Inductive Switching Test Circuit& Waveform

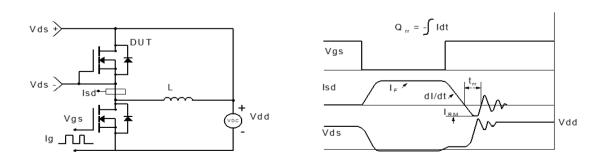
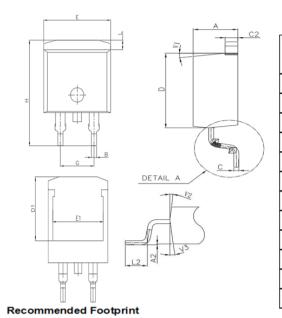


Figure 4: Diode Recovery Test Circuit & Waveform

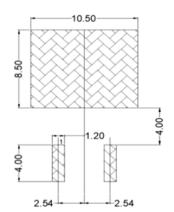


Package Mechanical Data(TO-263 -3L)

Package Outline



CAMPOL	DIMENSIONS				
SYMBOL	MIN	NOM	MAX		
A	4.3	4.55	4.7		
A2	0		0. 15		
В	0.75	0.8	0.85		
С	0.38	0.46	0. 55		
C2	1.25	1.3	1. 35		
D	8.9	9.3	9.6		
D1	7.4	7. 65	7.9		
Е	9.9	10.05	10.21		
E1	8.3	8.6	8.9		
G	5. 03	5. 08	5. 13		
Н	14.7	15	15.8		
L2	2.2	2.35	2.5		



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